

**Search Notes**

Application/Control No.

10/725,325

Examiner

Steven Loke

Applicant(s)/Patent under  
Reexamination

HSHIEH ET AL.

Art Unit

2811

**SEARCHED**

Class	Subclass	Date	Examiner
257	341, 342, 329, 330, 331	5/13/2004	SL
438	212, 259	5/13/2004	SL
438	270, 271	5/13/2004	SL
438	589, 588	5/13/2004	SL
438	587	5/13/2004	SL
above	updated	11/18/2004	SL
above	updated	9/5/2005	SL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR